Search Notes



Appli	ation	/Control	No.

Examiner

Jinhee J. Lee

10/509,393

STUDER, CHRISTOPH Art Unit

Applicant(s)/Patent under Reexamination

2831

SEARCHED						
Class	Subclass	Date	Examiner			
174	113R	7/23/2005	LEE			
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174	as above	1/6/2006	LEE			

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